

# Fast switching diode chip in Emitter Controlled Technology

### Features:

- 1200V technology 120 μm chip
- · soft, fast switching
- low reverse recovery charge
- small temperature coefficient
- qualified according to JEDEC for target applications

### Recommended for:

 power modules and discrete devices



## **Applications:**

SMPS, resonant applications, drives

| Chip Type    | $V_{R}$ | <i>I</i> <sub>Fn</sub> | Die Size                  | Package      |
|--------------|---------|------------------------|---------------------------|--------------|
| SIDC56D120F6 | 1200V   | 75A                    | 7.5 x 7.5 mm <sup>2</sup> | sawn on foil |

### **Mechanical Parameters**

| Die size               |                                  | 7.5 x 7.5  |               |  |
|------------------------|----------------------------------|--|---------------|--|
| Area total             |                                  | 56.25  | $\text{mm}^2$ |  |
| Anode pad size         |                                  | 6.78 x 6.78  |               |  |
| Thickness              |                                  | 120  | μm            |  |
| Wafer size             |                                  | 150  | mm            |  |
| Max. possible chips pe | er wafer                         | 248  |               |  |
| Passivation frontside  |                                  | Photoimide   |               |  |
| Pad metal              |                                  | 3200 nm AlSiCu   |               |  |
| Backside metal         |                                  | Ni Ag -system  |               |  |
| Die bond               |                                  | Electrically conductive epoxy glue and soft solder   |               |  |
| Wire bond              |                                  | Al, ≤500μm   |               |  |
| Reject ink dot size    |                                  | Ø 0.65mm; max 1.2mm  |               |  |
| Storage environment    | for original and sealed MBB bags | Ambient atmosphere air, Temperature 17°C – 25°C, < 6 month   |               |  |
|                        | for open MBB bags                | Acc. to IEC62258-3: Atmosphere >99% Nitrogen or ine<br>Humidity <25%RH, Temperature 17°C – 25°C, < 6 m |               |  |



# **Maximum Ratings**

| Parameter  | Symbol                    | Condition                      | Value   | Unit |
|--|---------------------------|--------------------------------|---------|------|
| Repetitive peak reverse voltage                  | $V_{RRM}$                 | T <sub>vj</sub> = 25 °C        | 1200    | V    |
| Continuous forward current                       | I <sub>F</sub>            | T <sub>vj</sub> < 150°C        | 1)      | ۸    |
| Maximum repetitive forward current <sup>2)</sup> | I <sub>FRM</sub>          | <i>T</i> <sub>vj</sub> < 150°C | 150     | A    |
| Operating junction and storage temperature       | $T_{\rm vj,} T_{\rm stg}$ |                                | -55+150 | °C   |

<sup>1)</sup> depending on thermal properties of assembly

# **Static Characteristics** (tested on wafer), $T_{vj} = 25$ °C

| Parameter                          | Symbol   | Conditions             | Value |      |      | Unit  |
|------------------------------------|----------|------------------------|-------|------|------|-------|
| rarameter                          |          |                        | min.  | typ. | max. | Oiiit |
| Reverse leakage current            | $I_{R}$  | V <sub>R</sub> =1200V  |       |      | 20   | μA    |
| Cathode-Anode breakdown<br>Voltage | $V_{BR}$ | I <sub>R</sub> =0.25mA | 1200  |      |      | V     |
| Forward voltage drop               | $V_{F}$  | / <sub>F</sub> =75A    | 1.68  | 2.1  | 2.42 |       |

# Electrical Characteristics (not subject to production test - verified by design/characterization)

| Parameter            |                                | Symbol Conditions | Conditions          | Value |      |      | Unit |
|----------------------|--------------------------------|-------------------|---------------------|-------|------|------|------|
|                      |                                |                   | min.                | typ.  | max. | Onne |      |
| Forward voltage drop | <i>T</i> <sub>vj</sub> = 125°C | V <sub>F</sub>    | I <sub>F</sub> =75A |       | 1.7  |      | V    |

## **Further Electrical Characteristics**

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

| This chip data sheet refers to the device data sheet | F4-75R12KS4_B11 | Rev. 2.0 |
|--|-----------------|----------|
|--|-----------------|----------|

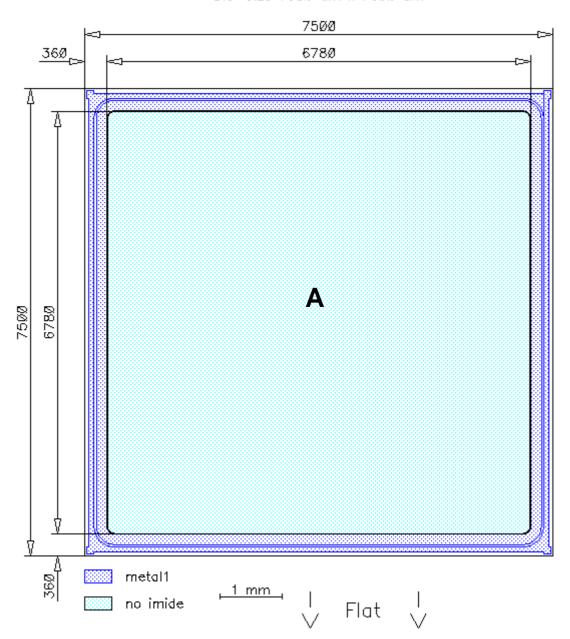
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<sup>&</sup>lt;sup>2)</sup> not subject to production test - verified by design/characterisation



# **Chip Drawing**

Die-Size 7500 um x 7500 um



A: Anode pad



| Description   |
|---|
| AQL 0,65 for visual inspection according to failure catalogue     |
| Electrostatic Discharge Sensitive Device according to MIL-STD 883 |
| Revision History  |

| Version | Subjects (major changes since last revision) | Date |
|---------|--|------|
|         |  |      |
|         |  |      |

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